



Interference Searched 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09912812	BEAN ET AL.
	Examiner Whipkey, Jason T	Art Unit 2622

Class	SubClass	Date	Examiner
-------	----------	------	----------

See interference search printout	6/7/06	JTW
----------------------------------	--------	-----

U.S. Patent and Trademark Office	Part of Paper No.: 20060607
----------------------------------	-----------------------------

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09912812	BEAN ET AL.
	Examiner Whipkey, Jason T	Art Unit 2622

Notes	Date	Examiner
Updated search	6/2/06	JTW
Dialog search	6/2/06	JTW
SPIE Library search	6/2/06	JTW
U.S. Patent and Trademark Office		Part of Paper No.: 20060607